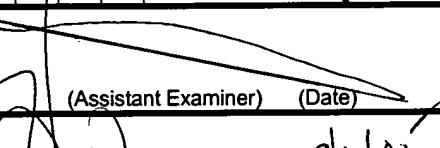
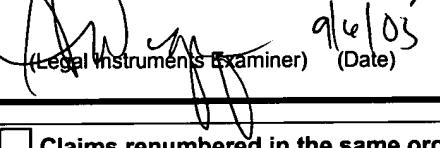
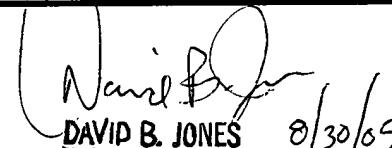


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/751,039	PARK, SHIN HEE
	Examiner	Art Unit
	David B. Jones	3725

ORIGINAL			CROSS REFERENCE(S)						
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						
72	56	29	419.2						
INTERNATIONAL CLASSIFICATION			72	54	430				
B23P	011/00								
B21D	26/14								
B60K	17/22								
	/								
	/								
 (Assistant Examiner) (Date)  (Legal Instruments Examiner) (Date)			 DAVID B. JONES 8/30/05 (Primary Examiner) (Date)						
Total Claims Allowed: 2 <table border="1"> <tr> <td>O.G. Print Claim(s)</td> <td>O.G. Print Fig.</td> </tr> <tr> <td>1</td> <td>2</td> </tr> </table>						O.G. Print Claim(s)	O.G. Print Fig.	1	2
O.G. Print Claim(s)	O.G. Print Fig.								
1	2								

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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12		42	72	102	132	162	192
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